

IDS - 11/10/2005

ELECTRONIC INFORMATION DISCLOSURE STATEMENT

Electronic Version v18

Stylesheet Version v18.0

Title of Invention	Elimination of RDL Using Tape Base Flip Chip on Flex for Die Stacking										
Application Number :	10/050507										
Confirmation Number:	7687										
First Named Applicant:	Teck Lee										
Attorney Docket Number:	MTI-31607										
Art Unit:	2813										
Examiner:	Jack SJ Chen										
Search string:	(6308525 or 5468995 or 6610559).pn										
US Patent Documents											
Note: Applicant is not required to submit a paper copy of cited US Patent Documents											
init	Cite.No.	Patent No.	Date	Patentee	Kind	Class	Subclass				
DAZ	1	6308525	2001-03-27	Imasu et al.		361	783				
DAZ	2	5468995	1995-11-21	Higgins III		257	697				
DAZ	3	6610559	2003-08-26	Wang et al.		438	108				
Signature											
<table border="1"> <tr> <td>Examiner Name</td> <td>Date</td> </tr> <tr> <td>/David Zarneke/</td> <td>05/22/2006</td> </tr> </table>				Examiner Name	Date	/David Zarneke/	05/22/2006				
Examiner Name	Date										
/David Zarneke/	05/22/2006										

IDS - 01/03/2006

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Application Number : 10/050507 
 Confirmation Number: 7687
 First Named Applicant: Teck Lee
 Attorney Docket Number: MTI-31607
 Art Unit: 2813
 Examiner: Jack SJ Chen
 Search string: (6624060 or 20020027080 or 20030134450).pn

US Patent Documents**Note: Applicant is not required to submit a paper copy of cited US Patent Documents**

init	Cite.No.	Patent No.	Date	Patentee	Kind	Class	Subclass
DAZ	1	6624060	2003-09-23	Chen et al.		438	613

US Published Applications**Note: Applicant is not required to submit a paper copy of cited US Published Applications**

init	Cite.No.	Pub. No.	Date	Applicant	Kind	Class	Subclass
DAZ	1	20020027080	2002-03-07	Yoshioka et al.	A1	205	123
DAZ	2	20030134450	2003-07-17	Lee	A1	438	106

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Examiner Name	Date
/David Zarneke/	05/22/2006

P10/SB/08a (08-03)

Approved for use through 07/31/2006. OMB 0651-0031
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INFORMATION DISCLOSURE STATEMENT BY APPLICANT <i>(Not for submission under 37 CFR 1.99)</i>	Application Number	10050507
	Filing Date	2002-01-16
	First Named Inventor	Teck Kheng Lee
	Art Unit	2891
	Examiner Name	David A. Zameke
Attorney Docket Number	MTI-31607	

U.S. PATENTS						<input type="button" value="Remove"/>
Examiner Initial*	Cite No	Patent Number	Kind Code ¹	Issue Date	Name of Patentee or Applicant of cited Document	Pages, Columns, Lines where Relevant Passages or Relevant Figures Appear
DAZ	1	5768109		1998-06-16	Gulick et al.	
	2	6285081	B1	2001-09-04	Jackson	
	3	6037665		2000-03-14	Miyazaki	
	4	6791195	B2	2004-09-14	Urushima	
	5	6373268	B1	2002-04-16	Dunlap et al.	

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↓	1	20020127769	A1	2002-09-12	Ma et al.	
DAZ	2	20030012930	A1	2003-01-16	Brousseau, III	

/David Zameke/

05/19/2006

**INFORMATION DISCLOSURE
STATEMENT BY APPLICANT**
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Art Unit	2891
Examiner Name	David A. Zameke
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US Patent Documents

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init	Cite.No.	Patent No.	Date	Patentee	Kind	Class	Subclass
DAZ	1	4415403	1983-11-15	Bakewell		216	27
DAZ	2	6847105	2005-01-25	Koopmans		257	686

Signature

Examiner Name	Date
/David Zarneke/	05/22/2006